

规格书编号

SPEC NO:

产品规格书 SPECIFICATION

CUSTOMER 客 户:					
PRODUCT 产品:	SAW FILTER				
MODEL NO 型 号:	HDF930A-F11				
PREPARED 编 制:	CHECKED 审 核:	:			
APPROVED 批 准:	DATE 日期:	2006-5-11			
客户确认 CUSTOMER R	ECEIVED:				
审核 CHECKED	批准 APPROVED	日期 DATE			

无锡市好达电子有限公司 Shoulder Electronics Limited



SAW FILTER HDF930A-F11

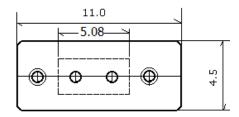
更改历史记录 History Record

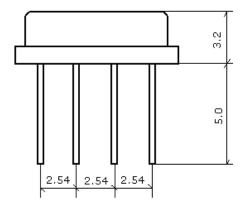
更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark



1. Package Dimension

Unit:mm





HDF930A

2. Marking

HD F930A

- 2.1 Color: Black or Blue
- 2.2 930.5: Center Frequency (MHz)

3. Performance

3.1Application

Low-Loss SAW Filter of cordless system.

Center Frequency: 930.5 MHz

3.2Maximum Rating

Operation Temperature Range	-20°C to +50°C	
Storage Temperature Range	-40°C to +85°C	
DC. Permissive Voltage	10 V . max.	
Maximum Input Power	0dBm	

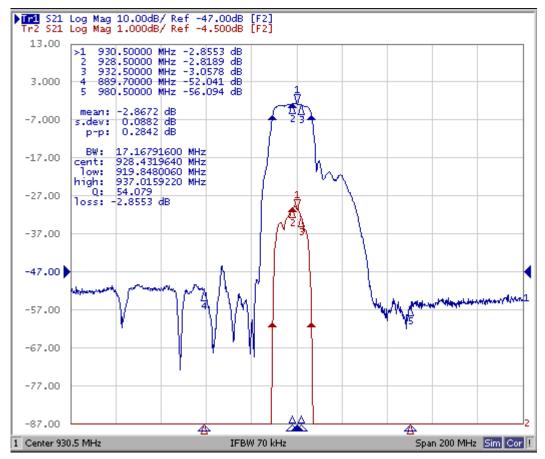


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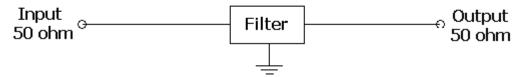
Electronic Characteristics

Item	Frequency	Specification
Center Frequency(fo)	930.5MHz	
Pass Band Width	$Fo \pm 2.0MHz$	
Insertion Loss	Passband	4.5dB max.
Stop Band Rejection	Fo-400~-40.8MHz	47dB min.
	Fo+50~+400MHz	47dB min.
Terminating Impedance		50Ω //<10nH
Operating Temperature Range		-10°C To +70°C

3.4 Frequency Characteristics



3.5Test Circuit



4. ENVIRONMENTAL CHARACTERISTICS

4-1 High temperature exposure

Subject the device to $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in table 1.



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4-2 Low temperature exposure

Subject the device to -20° C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in table 1.

4-3 Temperature cycling

Subject the device to a low temperature of -40° C for 30 minutes. Following by a high temperature of $+80^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in table 1.

4-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at 260° C $\pm 10^{\circ}$ C for 10 ± 1 sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in table 1.

4-5 Solderability

Subject the device terminals into the solder bath at 245° C $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in table 1.

4-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in table 1.

4-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in table 1.

4-8 Lead fatigue

4-8-1 Pulling test

Weight along with the direction of lead without an shock 1kg. The device shall satisfy all the initial Characteristics.

4-8-2 Bending test

Lead shall be subject to withstand against 90°C bending with 450g weight in the direction of thickness. This operation shall be done toward

5. REMARK

5.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

5.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

5.3 Soldering

Only leads of component may be soldered . Please avoid soldering another part of component.